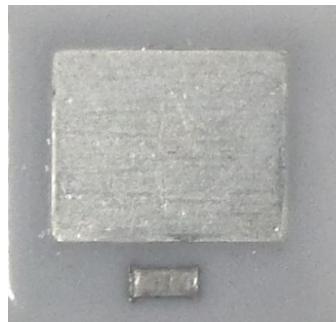


JME070-12/16/18/20

Description:

- 1) Chip: double mesa SCRs of reverse blocking high-voltage
- 2) Chip area: 9.8mm×9.8mm (edge gate thyristor)
- 3) Technology: mesa glass passivation technology, multilayer metallization technology and non-void welding by vacuum welding technology


Typical Application:

Reactive power compensation, solid state relay, power module, etc.

Absolute Maximum Ratings (Packaged into modules, unless otherwise specified, $T_C=25^\circ\text{C}$)

Parameter	Test Conditions	Symbol	Values	Unit
Operating junction temperature range		T_j	-40-125	°C
Repetitive peak off-state voltage	$T_j=25^\circ\text{C}$	V_{DRM}	1200/1600/1800/2000	V
Repetitive peak reverse voltage	$T_j=25^\circ\text{C}$	V_{RRM}	1200/1600/1800/2000	V
Average on-state current	$T_C=80^\circ\text{C}$	$I_{T(AV)}$	70	A
Peak on-state surge current	$tp=10\text{ms}$	I_{TSM}	1500	A
I^2t value for fusing	$tp=10\text{ms}$	I^2t	11250	A^2s
Critical rate of rise of on-state current	$V_D=2/3V_{DRM}$ $I_G=0.3\text{A}$ $tp=200\mu\text{s}$ $T_j=125^\circ\text{C}$ $dI_G/dt=0.3\text{A}/\mu\text{s}$	dl/dt	150	$\text{A}/\mu\text{s}$

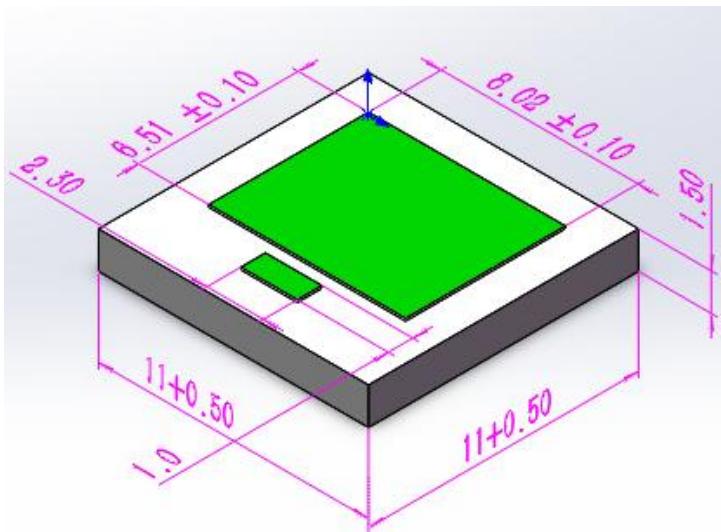
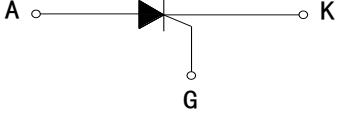
Electrical Characteristics (Packaged into modules, unless otherwise specified, $T_C=25^\circ\text{C}$)

Parameter	Test Conditions	Symbol	Values	Unit
Peak on-state voltage	$I_T=210\text{A}$ $tp=380\mu\text{s}$	V_{TM}	≤ 1.8	V
Repetitive peak off-state current	$V_D=V_{DRM}$ $T_C=25^\circ\text{C}$ $T_C=125^\circ\text{C}$	I_{DRM1} I_{DRM2}	≤ 50 ≤ 10	μA mA
Repetitive peak reverse current	$V_R=V_{RRM}$ $T_C=25^\circ\text{C}$ $T_C=125^\circ\text{C}$	I_{RRM1} I_{RRM2}	≤ 50 ≤ 10	μA mA
Triggering gate current	$V_D=12\text{V}$ $R_L=30\Omega$	I_{GT}	10-80	mA
Latching current	$I_G=1.2 I_{GT}$	I_L	≤ 200	mA
Holding current	$I_T=1\text{A}$	I_H	≤ 150	mA
Triggering gate voltage	$V_D=12\text{V}$ $R_L=30\Omega$	V_{GT}	≤ 2	V



Non triggering gate voltage	$V_D = V_{DRM}$ $T_j = 125^\circ\text{C}$	V_{GD}	≥ 0.25	V
Critical rate of rise of voltage Gate Open	$V_D = 2/3 V_{DRM}$ $T_j = 125^\circ\text{C}$	dV/dt	≥ 1000	V/ μs

Mechanical Characteristics

Module size	11 mm \times 11 mm
Module thickness	1.6 mm
Welding area of cathode electrode	8.1 mm \times 8.1 mm
Welding area of control electrode	2.3 mm \times 1 mm
	 symbol

Working Conditions

- 1) No severe mechanical shock as impact and drop off in the process of transportation, storage and working of product.
- 2) Storage conditions
 - Temperature: 5~40°C
 - Relative humidity: $\leq 45\%$
 - Storage time: 3 days for the open package; 3 months for the closed package
- 3) Welding conditions
 - Recommended solder component: Sn63Sb37 (or lead-free solder of liquid quadrant less than 240°C)
 - Recommended soldering conditions: shown in Table 1
- 4) Welding in the gate spot is recommended to be completed one-time by using fixture. If it is necessary to use a soldering iron, the temperature of soldering iron is controlled within 280°C and time is controlled within 20s.

Table 1

Sn63Sb37 Soldering conditions		
Average heating rate		3°C/s (Max)
Preheating activation	Low limit of temperature Ts(Min)	100°C
	Upper limit of temperature Ts(Max)	150°C
	Time (min ~ max) ts	60 ~ 90s
Reflow zone	Melting point temperature TL	183°C (Sn63Sb37)
	Peak temperature TP	240°C (+0/-5°C)
	Reflow time tp (Peak temperature ±5°C)	10~30s
	Melting time TL	40~60s
Maximum cooling rate		3.5°C/s
Recommended process time		300 ~ 360s
<p style="text-align: center;">Sn63Pb37</p>		

Ordering Information

<u>J</u>	<u>M</u>	<u>E</u>	<u>070</u>	<u>-16</u>	
JieJie Microelectronics Co.,Ltd					12:V _{DRM} /V _{RRM} ≥1200V 16:V _{DRM} /V _{RRM} ≥1600V 18:V _{DRM} /V _{RRM} ≥1800V 20:V _{DRM} /V _{RRM} ≥2000V
	<u>Module of series</u>				
		<u>E:Edge and corner gate</u>		<u>I_{T(AV)}=70A</u>	